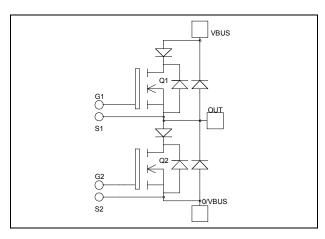
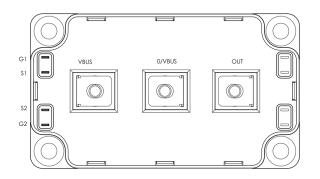


## Phase leg Series & SiC parallel diodes MOSFET Power Module





# APTM100A13SCG

 $V_{DSS} = 1000V$  $R_{DSon} = 130 m\Omega \text{ typ}$  @ Tj = 25°C  $I_D = 65A$  (a)  $Tc = 25^{\circ}C$ 

#### Application

- Motor control
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

#### Features

#### • Power MOS 7<sup>®</sup> MOSFETs

- Low R<sub>DSon</sub>
- Low input and Miller capacitance
- Low gate charge
- Avalanche energy rated
- Very rugged

#### • Parallel SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin source for easy drive
  - Very low stray inductance
  - Symmetrical design
  - M5 power connectors
- High level of integration

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

### All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

#### Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V <sub>DSS</sub>	Drain - Source Breakdown Voltage		1000	V
т	Continuous Drain Current	$T_c = 25^{\circ}C$	65	
I <sub>D</sub>	Continuous Drain Current	$T_c = 80^{\circ}C$	49	А
I <sub>DM</sub>	Pulsed Drain current		240	
V <sub>GS</sub>	Gate - Source Voltage		±30	V
R <sub>DSon</sub>	Drain - Source ON Resistance		156	mΩ
PD	Maximum Power Dissipation	$T_c = 25^{\circ}C$	1250	W
I <sub>AR</sub>	Avalanche current (repetitive and non repetitive)		24	А
E <sub>AR</sub>	Repetitive Avalanche Energy		30	mI
E <sub>AS</sub>	Single Pulse Avalanche Energy		1300	mJ

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 1000V$	$T_j = 25^{\circ}C$			600	μA
		$V_{GS} = 0V, V_{DS} = 800V$	$T_j = 125^{\circ}C$			2	mA
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 32.5A$			130	156	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 6mA$		3		5	V
I <sub>GSS</sub>	Gate – Source Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$				±450	nA

### **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
C <sub>iss</sub>	Input Capacitance	$V_{GS} = 0V$		15.2		
C <sub>oss</sub>	Output Capacitance	$V_{\rm DS} = 25 V$		2.6		nF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1MHz		0.42		
Qg	Total gate Charge	$V_{GS} = 10V$		562		
Q <sub>gs</sub>	Gate – Source Charge	$V_{Bus} = 500V$		75		nC
$Q_{gd}$	Gate – Drain Charge	$I_D = 65A$		363		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive switching @125°C		9		
Tr	Rise Time	$V_{GS} = 15V$		9		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 667V$ $I_D = 65A$		50		ns
$T_{\rm f}$	Fall Time	$R_G = 0.5\Omega$		24		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		1278		т
E <sub>off</sub>	Turn-off Switching Energy	$V_{GS} = 15V, V_{Bus} = 667V$ $I_D = 65A, R_G = 0.5\Omega$		462		μJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C		2671		т
$\mathrm{E}_{\mathrm{off}}$	Turn-off Switching Energy	$V_{GS} = 15V, V_{Bus} = 667V$ $I_D = 65A, R_G = 0.5\Omega$		570		μJ
R <sub>thJC</sub>	Junction to Case Thermal Resistance				0.1	°C/W

### Series diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Repetitive Reverse Voltage	e		1000			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1000V				350	μA
I <sub>F</sub>	DC Forward Current		$T_c = 100^{\circ}C$		120		Α
		$I_{\rm F} = 120 {\rm A}$			1.9	2.5	
V <sub>F</sub>	Diode Forward Voltage	$I_{\rm F} = 240 {\rm A}$			2.2		V
		$I_{\rm F} = 120 {\rm A}$	$T_j = 125^{\circ}C$		1.7		
+	$t_{rr}$ Reverse Recovery Time $I = 120 A$		$T_j = 25^{\circ}C$		280		20
ι <sub>rr</sub>		$T_j = 125^{\circ}C$		350		ns	
Qrr	Reverse Recovery Charge	$di/dt = 400 A/\mu s$ $T_j = 25^{\circ}C$	$T_j = 25^{\circ}C$		1520		nC
			$T_j = 125^{\circ}C$		7200		ne
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.46	°C/W



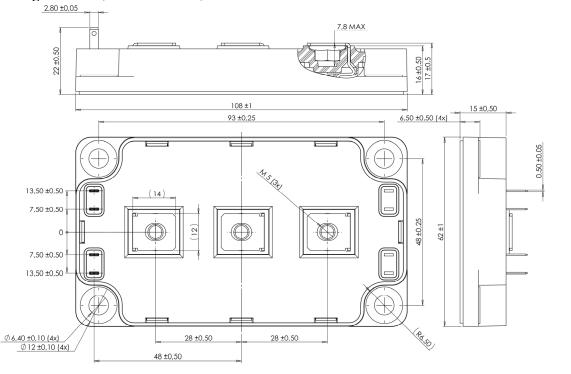
#### SiC Parallel diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Volta	age		1200			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1200V	$T_j = 25^{\circ}C$ $T_i = 125^{\circ}C$		400 800	1600 8000	μΑ
I <sub>F</sub>	DC Forward Current	$T_{1} = 125 ^{\circ}C$			40	0000	А
$\mathbf{V}_{\mathrm{F}}$	Diode Forward Voltage	$I_F = 40A \qquad \qquad \frac{T_i = 25^{\circ}C}{T_i = 175^{\circ}C}$			1.6 2.6	1.8 3.0	V
Qc	Total Capacitive Charge	$I_F = 40A, V_R = 600V$ di/dt = 2000A/µs			112		nC
Q	Total Capacitance	$f = 1 MHz, V_R = 200V$ $f = 1 MHz, V_R = 400V$			360 264		pF
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.35	°C/W

### Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case $t = 1 \text{ min}, 50/60 \text{Hz}$			4000			V
T <sub>J</sub>	Operating junction temperature range			-40		150	
T <sub>STG</sub>	Storage Temperature Range Operating Case Temperature					125	°C
T <sub>C</sub>						100	
Torquo	Mounting torque         To heatsink           For terminals	To heatsink	M6	3		5	N.m
Torque		M5	2		3.5	IN.III	
Wt	Package Weight					300	g

#### SP6 Package outline (dimensions in mm)



See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com

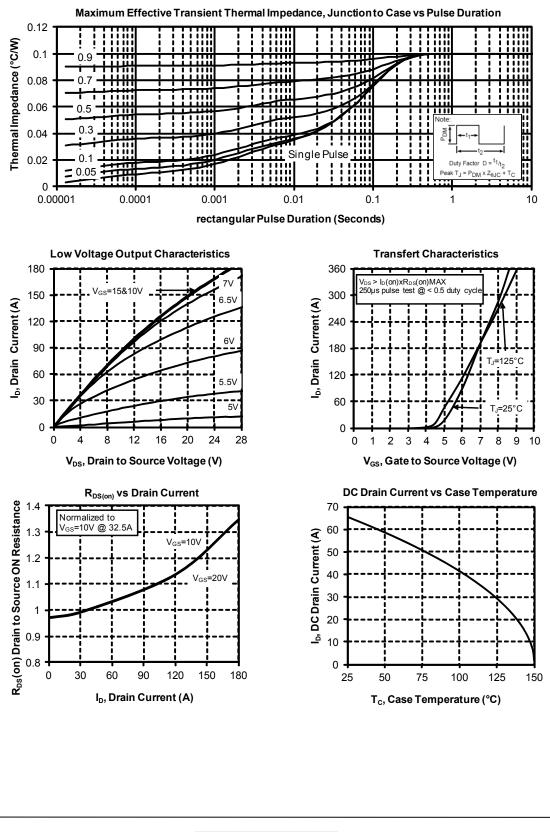
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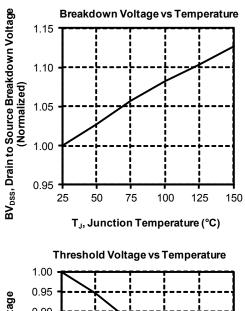


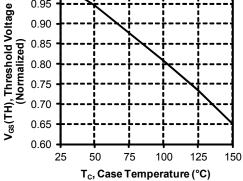
#### **Typical MOSFET Performance Curve**

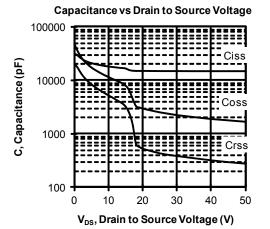


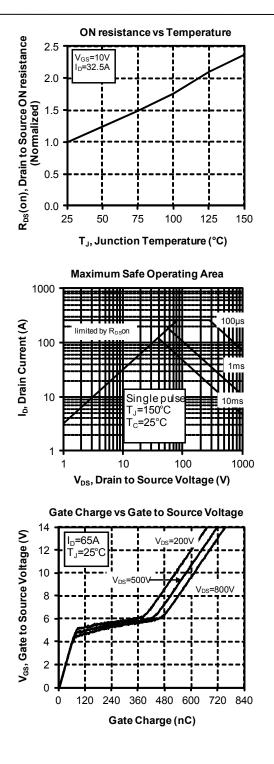
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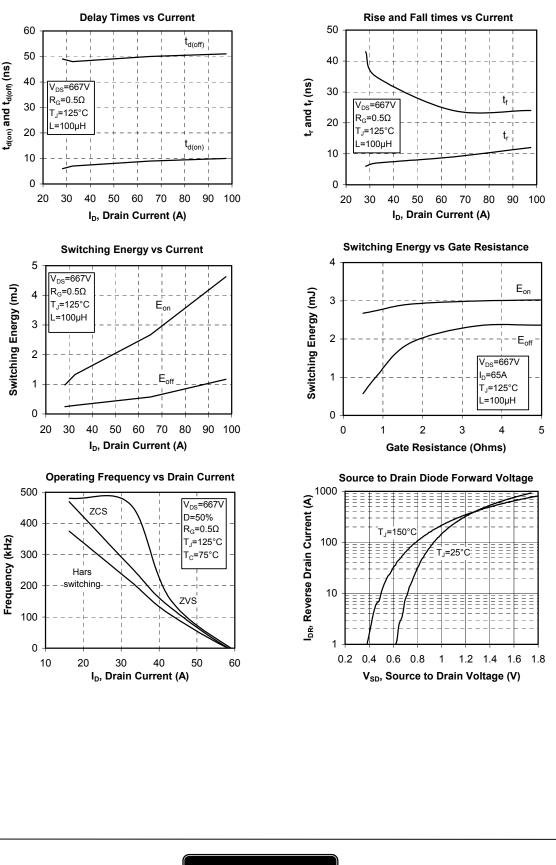


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t<sub>d(on)</sub> and t<sub>d(off)</sub> (ns)

# APTM100A13SCG

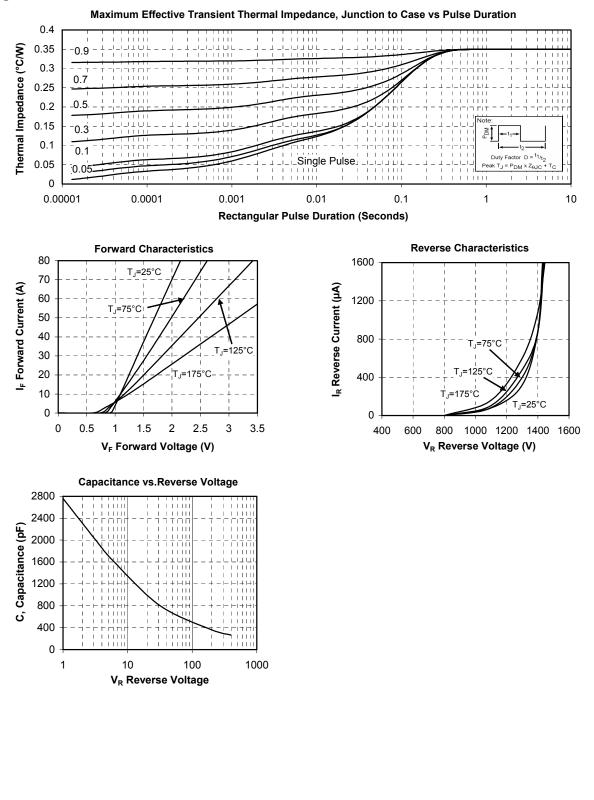


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#### **Typical SiC Diode Performance Curve**



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